

Appendix

Data sheet for the Motorola MRD500 photodiode.

MOTOROLA

SEMICONDUCTOR
TECHNICAL DATA

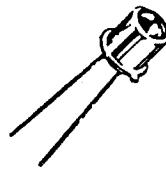
Photo Detectors Diode Output

**MRD500
MRD510**

... designed for application in laser detection, light demodulation, detection of visible and near infrared light-emitting diodes, shaft or position encoders, switching and logic circuits, or any design requiring radiation sensitivity, ultra high-speed, and stable characteristics.

- Ultra Fast Response — (<1 ns Typ)
- High Sensitivity — MRD500 (1.2 $\mu\text{A}/\text{mW}/\text{cm}^2$ Min)
MRD510 (0.3 $\mu\text{A}/\text{mW}/\text{cm}^2$ Min)
- Available With Convex Lens (MRD500) or Flat Glass (MRD510) for Design Flexibility
- Popular TO-18 Type Package for Easy Handling and Mounting
- Sensitive Throughout Visible and Near Infrared Spectral Range for Wide Application
- Annular Passivated Structure for Stability and Reliability

**PHOTO DETECTORS
DIODE OUTPUT
PIN SILICON
250 MILLIWATTS
100 VOLTS**



CASE 209-01
MRD500
(CONVEX LENS)



CASE Z10-01
MRD510
(FLAT GLASS)

MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Rating	Symbol	Value	Unit
Reverse Voltage	V_R	100	Volts
Total Power Dissipation @ $T_A = 25^\circ\text{C}$ Derate above 25°C	P_D	250 2.27	mW $\text{mW}/^\circ\text{C}$
Operating Temperature Range	T_A	-55 to +125	°C
Storage Temperature Range	T_{Stg}	-65 to -150	°C

STATIC ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Fig. No.	Symbol	Min	Typ	Max	Unit
Dark Current ($V_R = 20 \text{ V}$, $R_L = 1 \text{ megohm}$) Note 2 $T_A = 25^\circ\text{C}$ $T_A = 100^\circ\text{C}$	2 and 3	I_D	— —	— 14	2 —	nA
Reverse Breakdown Voltage ($I_R = 10 \mu\text{A}$)	—	$V_{(BR)R}$	100	200	—	Volts
Forward Voltage ($I_F = 50 \text{ mA}$)	—	V_F	—	—	1.1	Volts
Series Resistance ($I_F = 50 \text{ mA}$)	—	R_s	—	—	10	Ohms
Total Capacitance ($V_R = 20 \text{ V}$, $f = 1 \text{ MHz}$)	5	C_T	—	—	4	pF

OPTICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Light Current ($V_R = 20 \text{ V}$) Note 1	MRD500 MRD510	1	I_L	6 1.5	9 2.1	—	μA
Sensitivity at $0.8 \mu\text{m}$ ($V_R = 20 \text{ V}$) Note 3	MRD500 MRD510	—	$S(\lambda = 0.8 \mu\text{m})$	— —	6.6 1.5	— —	$\mu\text{A}/\text{mW}/\text{cm}^2$
Response Time ($V_R = 20 \text{ V}$, $R_L = 50 \text{ Ohms}$)	—	—	$t_{(\text{resp})}$	—	1	—	ns
Wavelength of Peak Spectral Response	5	—	λ_p	—	0.8	—	μm

NOTES: 1. Radiation Flux Density (H) equal to $5 \text{ mW}/\text{cm}^2$ emitted from a tungsten source at a color temperature of 2870 K .
2. Measured under dark conditions. ($H = 0$).
3. Radiation Flux Density (H) equal to $0.5 \text{ mW}/\text{cm}^2$ at $0.8 \mu\text{m}$.

TYPICAL CHARACTERISTICS

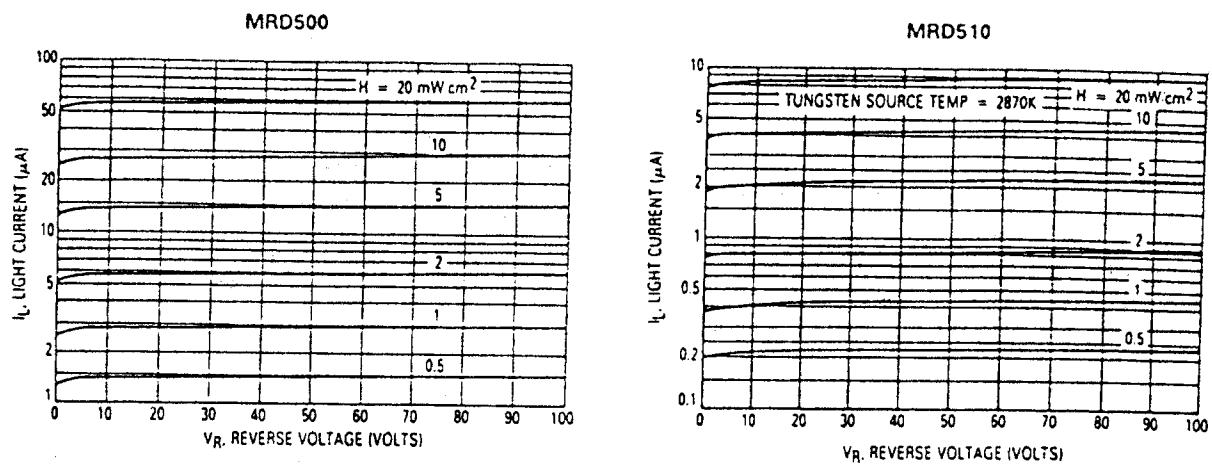


Figure 1. Irradiated Voltage — Current Characteristic

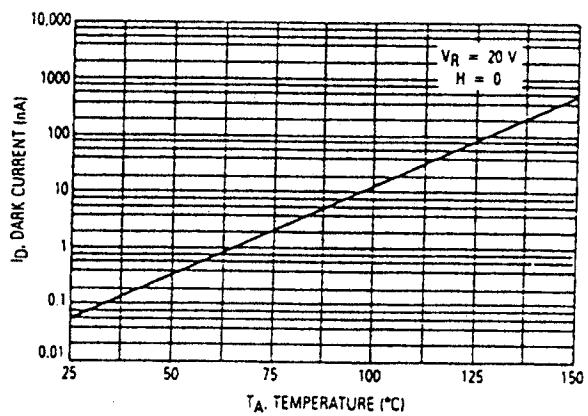


Figure 2. Dark Current versus Temperature

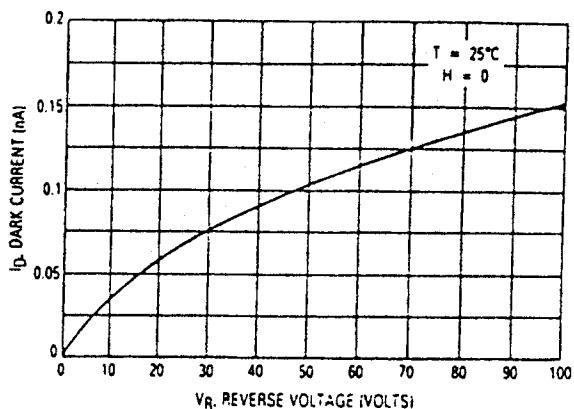


Figure 3. Dark Current versus Reverse Voltage

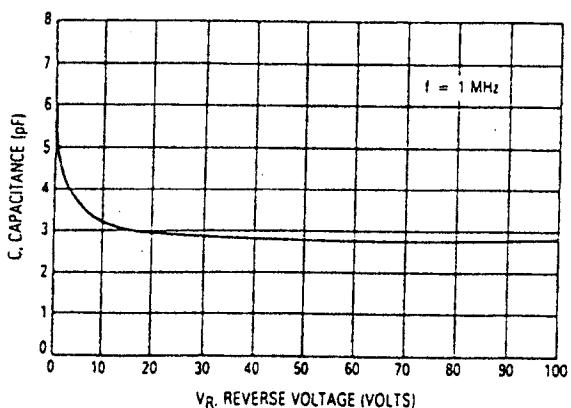


Figure 4. Capacitance versus Voltage

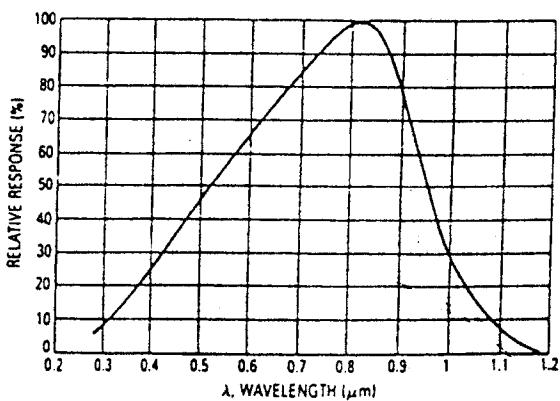


Figure 5. Relative Spectral Response